

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/562,629	YANG ET AL.	
Examiner	Art Unit	
Hongmin Fan	2612	

SEARCHED					
Class	Subclass	Date	Examiner		
340	538	7/26/2007	HF		
	584				
	600				
	628-630				
	506				
	521-525				
	531				
	310.11+				
250	339.15				
	554				
307	1-3				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
B. Lee	9/26/2007	HF		